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|-----------------------------------|--|---------------------------------|---|-------------|
| <b>Notice of References Cited</b> |  | Application/Control No.         | Applicant(s)/Patent Under Reexamination<br>LEE ET AL. |             |
|                                   |  | Examiner<br>Christopher R. Lamb | Art Unit<br>2627                                      | Page 1 of 1 |

**U.S. PATENT DOCUMENTS**

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| * | B | US-2002/0136134                                  | 09-2002         | Ito et al.   | 369/53.36      |
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**FOREIGN PATENT DOCUMENTS**

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